Se	arcn Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/725,595	LYU, JAE-JIN
Examiner	Art Unit
W. Patty Chen	2871

SEARCHED				
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Reviewed previously cited references	10/13/2006	WPÇ
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